



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE  
(Our Case No. 13347US02)

2622  
IFW

In The Application Of:

Whittingham et al.

Serial No.: 09/986,226

Filed: October 22, 2001

Examiner: Not known

Group Art Unit: 2622

For: RATIOING ALGORITHM FOR A  
LABEL PRINTING SYSTEM USING  
PLATES

**CERTIFICATE OF MAILING**

I hereby certify that this correspondence is  
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December 16, 2004

By: Jean D. Kuelper

Reg: No.: 30,171

**INFORMATION DISCLOSURE STATEMENT**

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Dear Sir:

It is respectfully requested that the patents listed on the enclosed PTO form 1449 be considered in the examination of the above-identified patent application. A copy of each cited reference is enclosed. Please initial the citations considered on PTO form 1449 and the enclosed copy thereof and return one copy.

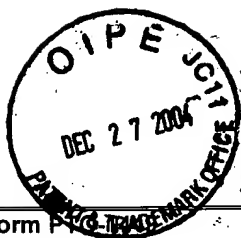
Please charge any additional fees associated with this Information Disclosure Statement to the deposit account of McAndrews, Held & Malloy, Ltd., Account No. 13-0017.

Respectfully submitted,

Dated: December 16, 2004

Jean Dudek Kuelper  
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Form PTO-136 (Rev. 8-83)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO. 13347US02	SERIAL NO. 09/986,226
INFORMATION DISCLOSURE CITATION (Use several sheets if necessary)		APPLICANT(s): Whittingham et al.	
		FILING DATE 10/22/01	GROUP ART UNIT: 2622

## U.S. PATENT DOCUMENTS

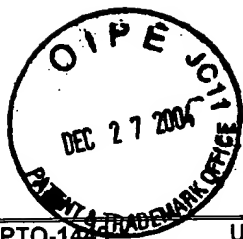
EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUBCLAS S	FILING DATE IF APPROPRIATE
	A	5,227,643	07-13-93	Craig et al.			
	B	5,239,622	08-24-93	Best et al.			
	C	5,287,434	02-15-94	Bain et al.			
	D	5,345,091	09-06-94	Craig et al.			
	E	5,621,864	04-15-97	Benade et al.			
	F	5,930,810	07-27-99	Farros et al.			
	G	6,018,338	01-25-00	Greulich et al.			
	H	US-2002/0030854	03-14-02	Schutz et al.			
	I	US-2002/0154338	10-24-02	Tanaka			
	J	US-2003/0004946	01-02-03	VanDenAvond et al.			
	K						
	L						
	M						

## FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
	N	WO 01/55869 A1	01-23-01	PCT				
	O	WO 01/66349 A1	03-02-01	PCT				
	P							
	Q							
	R							
	S							
	T							
	U							

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

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Form PTO-1449  
(Rev. 8-83)U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.  
13347US02SERIAL NO.  
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(Use several sheets if necessary)APPLICANT(s):  
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UNIT: 2622

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